

4-bit dual supply level translator without direction control pin

Datasheet –production data

Features

- 45 MHz: 90 Mbps (max.) data rate at $V_L = 1.8\text{ V}$, $V_{CC} = 3.3\text{ V}$
- Bi-directional level translation without direction control pin
- Wide voltage range ($V_L \leq V_{CC}$):
 - V_L ranges from 1.65 to 3.6 V
 - V_{CC} ranges from 1.65 to 5.5 V
- Totem-pole driving
- 5.5 V tolerant enable pin
- ESD performance on all pins: $\pm 2\text{ kV HBM}$
- Small package and footprint
QFN12 (1.7 x 2.0 mm)

Applications

- Low-voltage system level translation
- Mobile phones and other mobile devices

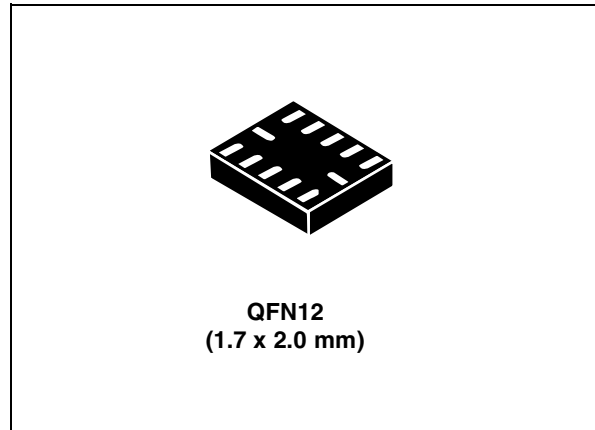


Table 1. Device summary

Order code	Package	Packing	Package topmark
ST2149BQTR	QFN12 (1.7 x 2.0 mm)	Tape and reel (3000 parts per reel)	49A

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1 Description

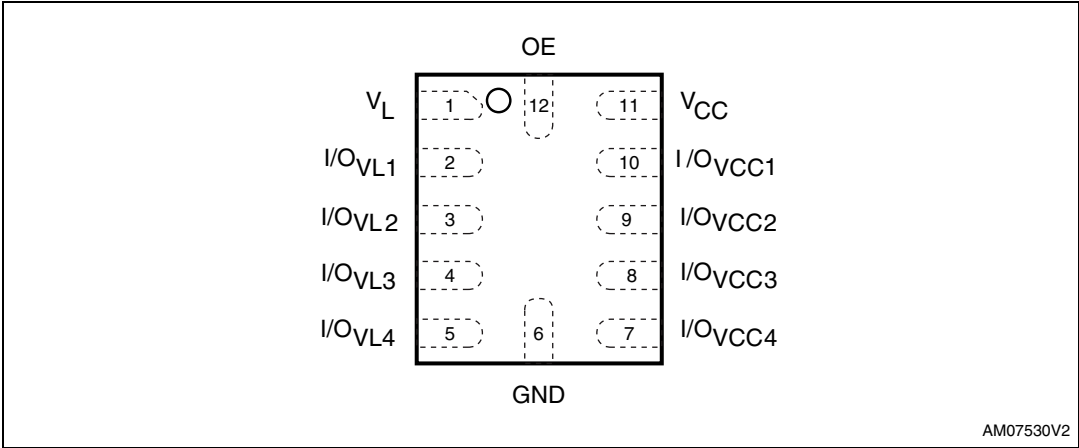
The ST2149B is a 4-bit dual supply level translator which provides the level shifting capability to allow data transfer in a multi-voltage system. Externally applied voltages, V_{CC} and V_L , set the logic levels on either side of the device. Its architecture allows bi-directional level translation without a control pin.

The ST2149B accepts V_L from 1.65 to 3.6 V and V_{CC} from V_L to 5.5 V, making it ideal for data transfer between low-voltage ASICs/PLD and higher voltage systems. This device has a tri-state output mode which can be used to disable all I/Os.

2 Pin settings

2.1 Pin connection

Figure 1. Pin connection (top through view)



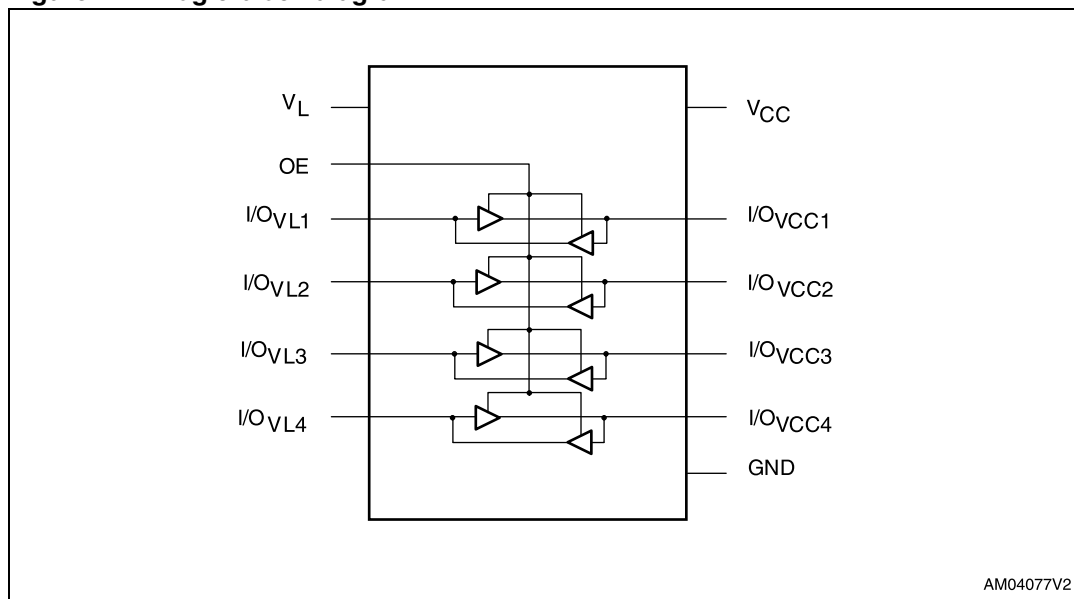
2.2 Pin description

Table 2. Pin description

Pin number	Symbol	Name and function
1	V_L	Supply voltage
2	I/O_{VL1}	Data input/output
3	I/O_{VL2}	Data input/output
4	I/O_{VL3}	Data input/output
5	I/O_{VL4}	Data input/output
6	GND	Ground
7	I/O_{VCC4}	Data input/output
8	I/O_{VCC3}	Data input/output
9	I/O_{VCC2}	Data input/output
10	I/O_{VCC1}	Data input/output
11	V_{CC}	Supply voltage
12	OE	Output enable

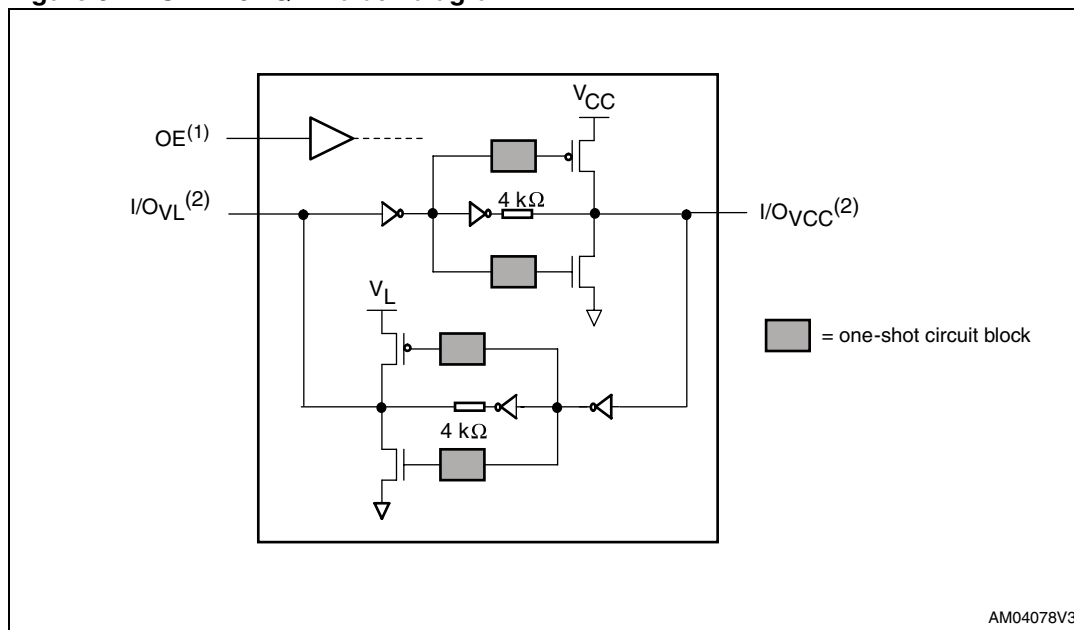
3 Logic diagram

Figure 2. Logic block diagram



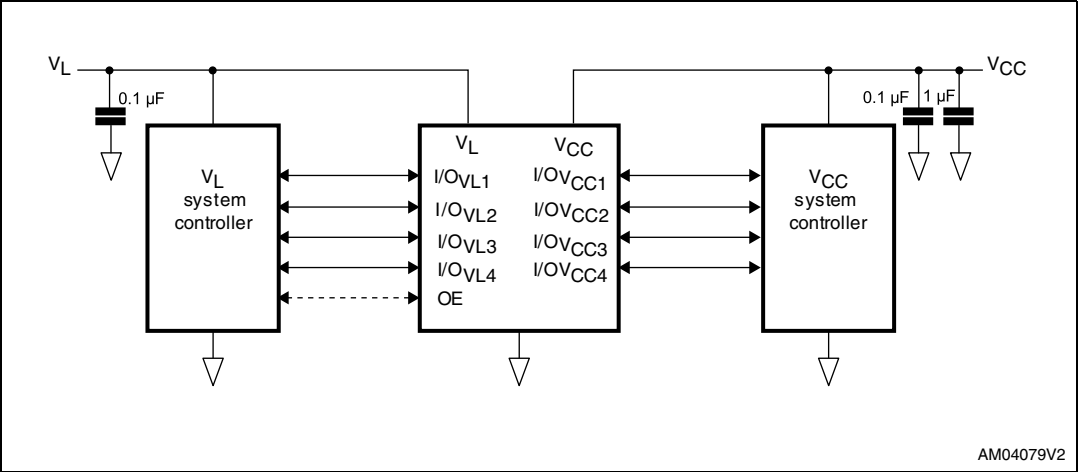
Device block diagrams

Figure 3. ST2149BQTR block diagram



1. When OE is LOW, all I/Os are in high-impedance mode.
2. ST2149BQTR has 4 channels. For simplicity, the above diagram shows only 1 channel.

Figure 4. Application block diagram



4 Supplementary notes

4.1 Driver requirement

For proper operation, the driver from each side of the device must be able to source and sink a minimum of 1 mA current. The device architecture requires the driver to source/sink maximum current of ($V_{CC}/4$) mA to/from the weak 4 k Ω output buffer.

4.2 Load driving capability

To support the architecture that allows level translation without the direction pin, the one-shot transistor is turned ON only during state transition at the output side. After the one-shot transistor is turned OFF, only the 4 k Ω resistor maintains the output logic state. So, a resistive load or pull-up resistor less than 50 k Ω is not recommended for proper operation.

4.3 Truth table

Table 3. Truth table

Enable	Bi-directional input/output	
OE	I/O _{VCC}	I/O _{VL}
H ⁽¹⁾	H ⁽²⁾	H ⁽¹⁾
H ⁽¹⁾	L	L
L	Z ⁽³⁾	Z ⁽³⁾

1. High level V_L power supply referred.
2. High level V_{CC} power supply referred.
3. Z = high impedance.

5 Maximum ratings

Stressing the device above the ratings listed in [Table 4](#) may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in [Recommended operating conditions](#) of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_L	Supply voltage	-0.3 to 4.6	V
V_{CC}	Supply voltage	-0.3 to 6.5	V
V_{OE}	DC control input voltage	-0.3 to 6.5	V
$V_{I/OVL}$	DC I/O _{VL} input voltage (OE = GND or V_L)	-0.3 to $V_L + 0.3$	V
$V_{I/OVCC}$	DC I/O _{VCC} input voltage (OE = GND or V_L)	-0.3 to $V_{CC} + 0.3$	V
I_{IK}	DC input diode current	-20	mA
$I_{I/OVL}$	DC output current	±25	mA
$I_{I/OVCC}$	DC output current	±25	mA
I_{SCTOUT}	Short-circuit duration, continuous	40	mA
P_D	Power dissipation	500	mW
T_{STG}	Storage temperature	-65 to 150	°C
T_L	Lead temperature (10 seconds)	300	°C
ESD	Electrostatic discharge protection (HBM)	±2	kV

Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Min.	Typ.	Max.	Unit
V_L	Supply voltage	1.65	–	3.6	V
V_{CC}	Supply voltage	V_L	–	5.5	V
V_{OE}	Input voltage (OE output enable pin, V_L power supply referred)	0	–	3.6	V
$V_{I/OVL}$	I/O _{VL} voltage	0	–	V_L	V
$V_{I/OVCC}$	I/O _{VCC} voltage	0	–	V_{CC}	V
T_{OP}	Operating temperature	-40	–	85	°C
dt/dV	Input rise and fall time	0	–	1	ns/V

6 Electrical characteristics

Over recommended operating conditions unless otherwise noted. All typical values are at $T_A = 25\text{ }^{\circ}\text{C}$.

Table 6. DC characteristics

Symbol	Parameter	V _L	V _{CC}	Test conditions	Value					Unit
					T _A = 25 °C			-40 to 85 °C		
					Min.	Typ.	Max.	Min.	Max.	
V _{IHL}	High-level input voltage (I/O _{VL})	1.65 to 3.6	V _L to 5.5		0.8 V _L	–	–	0.8 V _L	–	V
V _{ILL}	Low-level input voltage (I/O _{VL})	1.65 to 3.6	V _L to 5.5		–	–	0.2 V _L	–	0.2 V _L	V
V _{IHC}	High-level input voltage (I/O _{VCC})	1.65 to 3.6	V _L to 5.5		0.8 V _{CC}	–	–	0.8 V _{CC}	–	V
V _{ILC}	Low-level input voltage (I/O _{VCC})	1.65 to 3.6	V _L to 5.5		–	–	0.2 V _{CC}	–	0.2 V _{CC}	V
V _{IH-OE}	High-level input voltage (OE)	1.65 to 3.6	V _L to 5.5		0.8 V _L	–	–	0.8 V _L	–	V
V _{IL-OE}	Low-level input voltage (OE)	1.65 to 3.6	V _L to 5.5		–	–	0.2 V _L	–	0.2 V _L	V
V _{OHL}	High-level output voltage (I/O _{VL})	1.65 to 3.6	V _L to 5.5	IO = -60 μA	V _L - 0.4	–	–	V _L - 0.4	–	V
V _{OLL}	Low-level output voltage (I/O _{VL})	1.65 to 3.6	V _L to 5.5	IO = +60 μA	–	–	0.4	–	0.4	V
V _{OHC}	High-level output voltage (I/O _{VCC})	1.65 to 3.6	V _L to 5.5	IO = -60 μA	V _{CC} - 0.4	–	–	V _{CC} - 0.4	–	V
V _{OLC}	Low-level output voltage (I/O _{VCC})	1.65 to 3.6	V _L to 5.5	IO = +60 μA	–	–	0.4	–	0.4	V
I _{OE}	Control input leakage current (OE)	1.65 to 3.6	V _L to 5.5	V _I = GND or V _L	–	–	0.1	–	1	μA

Table 6. DC characteristics (continued)

Symbol	Parameter	V _L	V _{CC}	Test conditions	Value					Unit
					T _A = 25 °C			-40 to 85 °C		
					Min.	Typ.	Max.	Min.	Max.	
I _{IO_LKG}	High impedance leakage current (I/O _{VL} , I/O _{VCC})	1.65 to 3.6	V _L to 5.5	OE = GND I/O _{VL} = high I/O _{VCC} = low	—	—	0.1	—	1	μA
				OE = GND I/O _{VL} = low I/O _{VCC} = high	—	—	0.1	—	1	μA
I _{QVCC}	Quiescent supply current V _{CC}	1.65 to 3.6	V _L to 5.5	OE = V _L	—	—	7	—	9	μA
I _{QVL}	Quiescent supply current V _L	1.65 to 3.6	V _L to 5.5	OE = V _L	—	—	0.1	—	1	μA
I _{Z-VCC}	High impedance quiescent supply current V _{CC}	1.65 to 3.6	V _L to 5.5	OE = GND I/O = Hi-Z	—	—	0.1	—	1	μA
I _{Z-VL}	High impedance quiescent supply current V _L	1.65 to 3.6	V _L to 5.5	OE = GND I/O = Hi-Z	—	—	0.1	—	1	μA

AC characteristics

Load $C_L = 15$ pF; driver $t_r = t_f \leq 6$ ns over temperature range -40 °C to 85 °C.

Table 7. AC characteristics - test conditions: $V_L = 1.65 - 1.95$ V

Symbol	Parameter	V _{CC} = V _L -1.95 V		V _{CC} = 2.3-2.7 V		V _{CC} = 3.0-3.6 V		V _{CC} = 4.5-5.5 V		Unit	
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t _{RVCC}	Rise time I/O _{VCC}	-	5.2	-	3.2	-	2.4	-	1.8	ns	
t _{FVCC}	Fall time I/O _{VCC}	-	3.2	-	1.5	-	1.3	-	1.2	ns	
t _{RVL}	Rise time I/O _{VL}	-	3.3	-	3.3	-	3.3	-	3.3	ns	
t _{FVL}	Fall time I/O _{VL}	-	1.5	-	1.4	-	1.4	-	1.3	ns	
t _{I/OVL-VCC}	Propagation delay time										
	I/O _{VL-LH} to I/O _{VCC-LH}	t _{PLH}	-	7.6	-	5.8	-	5.0	-	4.4	ns
	I/O _{VL-HL} to I/O _{VCC-HL}	t _{PHL}	-	4.6	-	3.9	-	3.9	-	3.5	ns
t _{I/OVCC-VL}	Propagation delay time										
	I/O _{VCC-LH} to I/O _{VL-LH}	t _{PLH}	-	7.1	-	6.6	-	4.8	-	4.6	ns
	I/O _{VCC-HL} to I/O _{VL-HL}	t _{PHL}	-	5.3	-	5.1	-	4.3	-	4.1	ns
t _{PZL}	Output enable time t _{PZL}	-	28	-	28	-	28	-	28	ns	
t _{PZH}	Output enable time t _{PZH}	-	90	-	90	-	90	-	90	ns	
t _{PLZ}	Output disable time t _{PLZ}		120	-	120	-	120	-	120	ns	
t _{PHZ}	Output disable time t _{PHZ}		80	-	60	-	50	-	50	ns	
D _R	Data rate ⁽¹⁾	56	-	90	-	90	-	90	-	Mbps	

1. Data rate is guaranteed based on the condition that output I/O signal rise/fall time is less than 15% of period of input I/O signal; input I/O signal is at 50% duty cycle and output I/O signal duty cycle deviation is less than $50\% \pm 10\%$.

Table 8. AC characteristics - test conditions: $V_L = 2.3 - 2.7\text{ V}$

Symbol	Parameter		$V_{CC} = V_L - 2.7\text{ V}$		$V_{CC} = 3.0 - 3.6\text{ V}$		$V_{CC} = 4.5 - 5.5\text{ V}$		Unit
			Min.	Max.	Min.	Max.	Min.	Max.	
t_{RVCC}	Rise time I/O_{VCC}		-	3.3	-	2.2	-	1.7	ns
t_{FVCC}	Fall time I/O_{VCC}		-	1.7	-	1.6	-	1.4	ns
t_{RVL}	Rise time I/O_{VL}		-	2.2	-	2.2	-	1.9	ns
t_{FVL}	Fall time I/O_{VL}		-	1.3	-	1.2	-	1.2	ns
$t_{I/OVL-VCC}$	Propagation delay time								
	I/O_{VL-LH} to I/O_{VCC-LH}	t_{PLH}	-	4.8	-	4.3	-	3.9	ns
	I/O_{VL-HL} to I/O_{VCC-HL}	t_{PHL}	-	3.7	-	3.3	-	2.9	ns
$t_{I/OVCC-VL}$	Propagation delay time								
	I/O_{VCC-LH} to I/O_{VL-LH}	t_{PLH}	-	3.9	-	3.5	-	3.5	ns
	I/O_{VCC-HL} to I/O_{VL-HL}	t_{PHL}	-	3.6	-	3.5	-	3.4	ns
t_{PZL}	Output enable time t_{PZL}		-	25	-	25	-	25	ns
t_{PZH}	Output enable time t_{PZH}		-	100	-	100	-	70	ns
t_{PLZ}	Output disable time t_{PLZ}		-	90	-	90	-	90	ns
t_{PHZ}	Output disable time t_{PHZ}		-	50	-	50	-	50	ns
D_R	Data rate ⁽¹⁾		90	-	136	-	158	-	Mbps

1. Data rate is guaranteed based on the condition that output I/O signal rise/fall time is less than 15% of period of input I/O signal; input I/O signal is at 50% duty cycle and output I/O signal duty cycle deviation is less than $50\% \pm 10\%$.

Table 9. AC characteristics - test conditions: $V_L = 3.0 - 3.6 \text{ V}$

Symbol	Parameter		$V_{CC} = V_L - 3.6 \text{ V}$		$V_{CC} = 4.5 - 5.5 \text{ V}$		Unit
			Min.	Max.	Min.	Max.	
t_{RVCC}	Rise time I/O_{VCC}		-	2.1	-	1.7	ns
t_{FVCC}	Fall time I/O_{VCC}		-	1.3	-	1.3	ns
t_{RVL}	Rise time I/O_{VL}		-	1.6	-	1.5	ns
t_{FVL}	Fall time I/O_{VL}		-	1.1	-	1.1	ns
$t_{I/OVL-VCC}$	Propagation delay time						
	I/O_{VL-LH} to I/O_{VCC-LH}	t_{PLH}	-	4.1	-	4.1	ns
	I/O_{VL-HL} to I/O_{VCC-HL}	t_{PHL}	-	2.9	-	2.6	ns
$t_{I/OVCC-VL}$	Propagation delay time						
	I/O_{VCC-LH} to I/O_{VL-LH}	t_{PLH}	-	4.0	-	4.0	ns
	I/O_{VCC-HL} to I/O_{VL-HL}	t_{PHL}	-	2.6	-	2.5	ns
t_{PZL}	Output enable time t_{PZL}		-	15	-	15	ns
t_{PZH}	Output enable time t_{PZH}		-	70	-	15	ns
t_{PLZ}	Output disable time t_{PLZ}		-	70	-	70	ns
t_{PHZ}	Output disable time t_{PHZ}		-	50	-	50	ns
D_R	Data rate ⁽¹⁾		144	-	186	-	Mbps

1. Data rate is guaranteed based on the condition that output I/O signal rise/fall time is less than 15% of period of input I/O signal; input I/O signal is at 50% duty cycle and output I/O signal duty cycle deviation is less than $50\% \pm 10\%$.

7 Test circuit

Figure 5. Test circuit

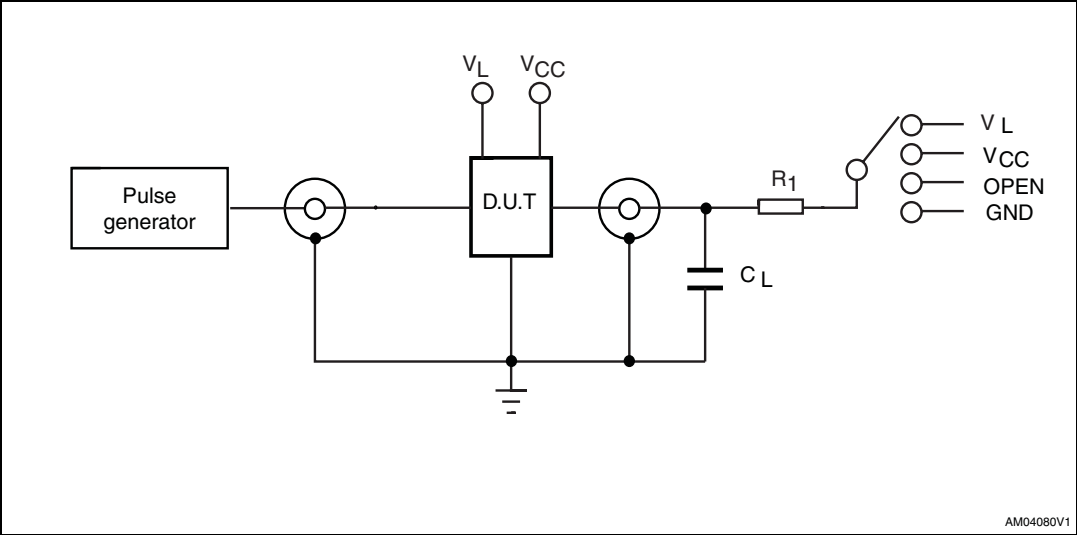


Table 10. Test circuit switches

Test	C_L	R_1	Switch
t_{PLH} , t_{PHL}	15 pF	20 k Ω	Open
t_r , t_f	15 pF	20 k Ω	Open
t_{PZL} , t_{PLZ}	15 pF	20 k Ω	V_L or V_{CC}
t_{PZH} , t_{PHZ}	15 pF	20 k Ω	GND

Table 11. Waveform symbol value

Symbol	Driving I/O $_{VL}$		Driving I/O $_{VCC}$	
	$1.65\text{ V} \leq V_L \leq V_{CC} \leq 2.5\text{ V}$	$3.3\text{ V} \leq V_L \leq V_{CC} \leq 5.5\text{ V}$	$1.65\text{ V} \leq V_L \leq V_{CC} \leq 2.5\text{ V}$	$3.3\text{ V} \leq V_L \leq V_{CC} \leq 5.5\text{ V}$
V_{IH}	V_L	V_L	V_{CC}	V_{CC}
V_{IM}	50% V_L	50% V_L	50% V_{CC}	50% V_{CC}
V_{OM}	50% V_{CC}	50% V_{CC}	50% V_L	50% V_L

Figure 6. Waveform - propagation delay ($f = 1\text{ MHz}$, 50% duty cycle)

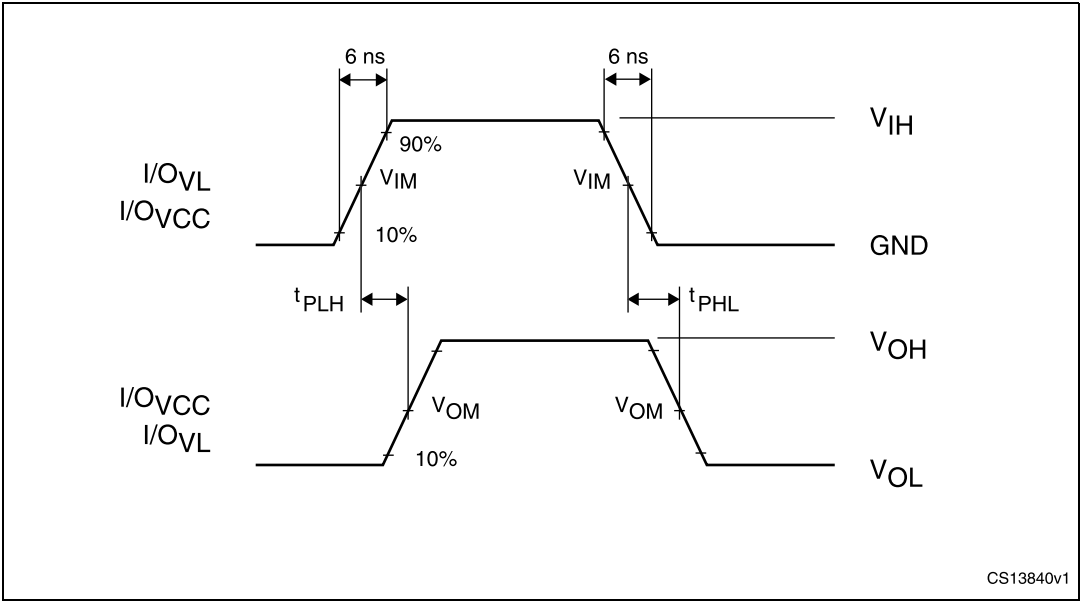
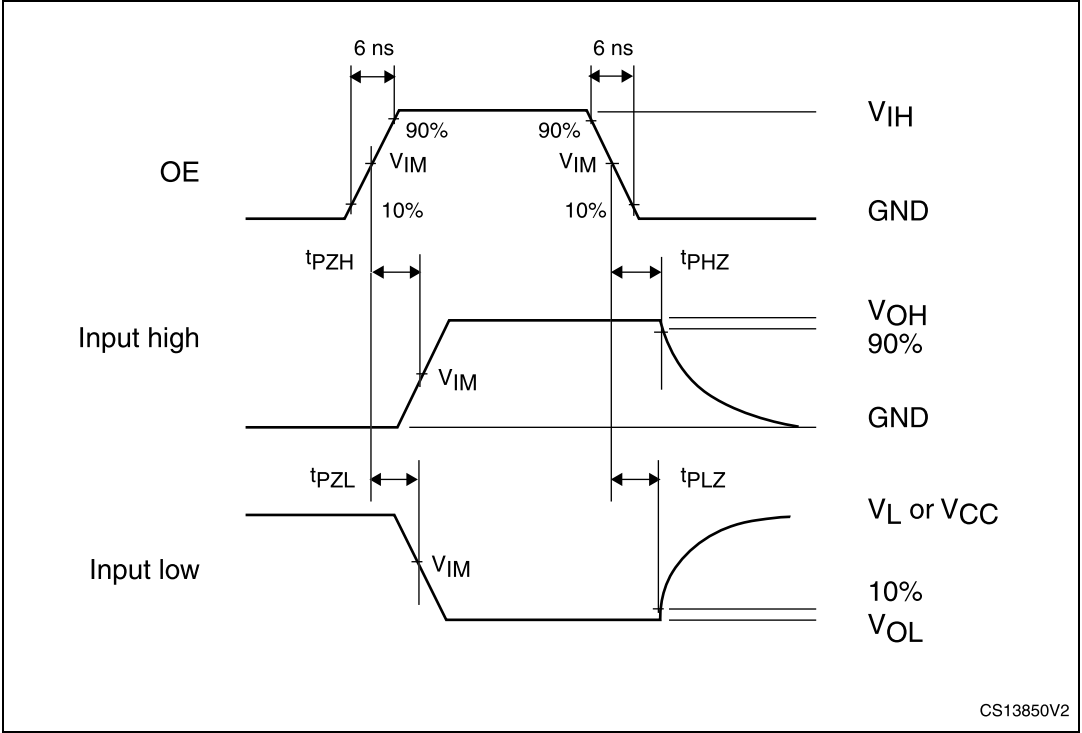


Figure 7. Waveform - output enable and disable time ($f = 1\text{ MHz}$, 50% duty cycle)



8 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Figure 8. Package outline for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

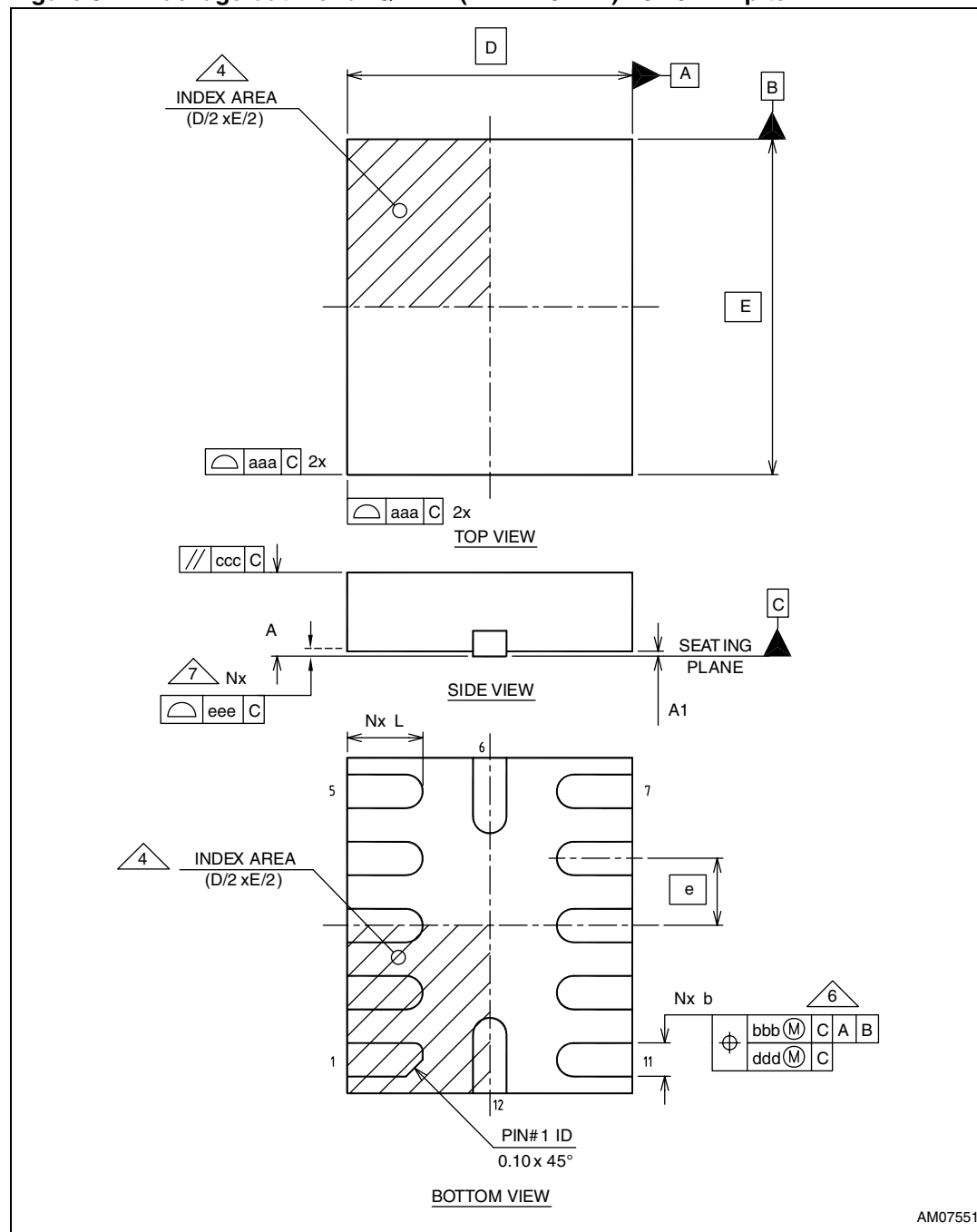
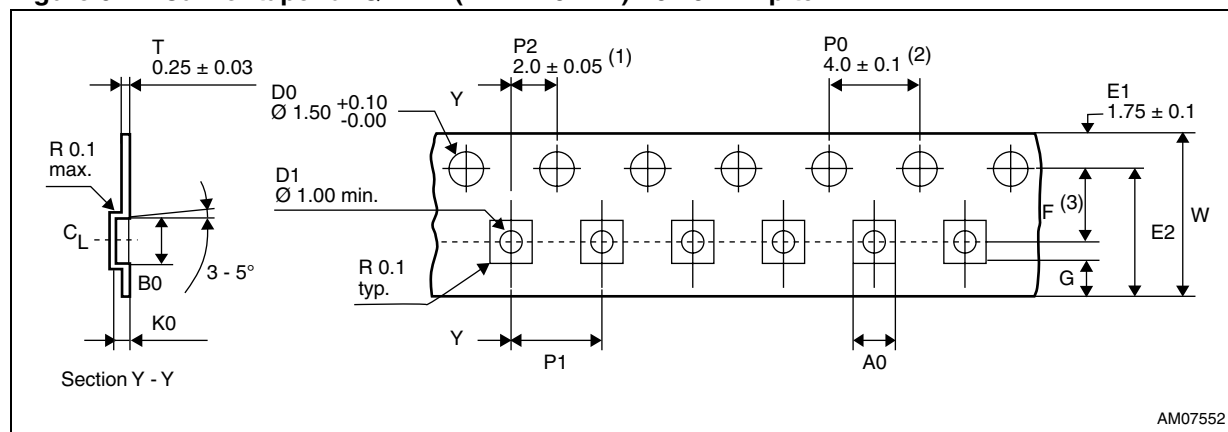


Table 12. Mechanical data for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

Symbol	Dimensions		
	mm.		
	Min.	Nom.	Max.
A	0.45	0.50	0.55
A1	0.00	0.02	0.05
b	0.15	0.20	0.25
D	1.70 BSC		
E	2.00 BSC		
e	0.40 BSC		
L	0.35	0.45	0.55
aaa	0.05		
bbb	0.07		
ccc	0.10		
ddd	0.05		
eee	0.08		
N	12		
ND	1		
NE	5		
Notes	(1), (2)		
LF part No.	-		
LF DWG. No.	B-2888		

1. Dimensioning and tolerance conform to ASME Y14.5M-1994.
2. All dimensions are in millimeters.
3. N is the total number of terminals.
4. The location of the terminal #1 identifier and terminal numbering convention conforms to JEDEC publication 95 SPP-002.
5. ND and NE refer to the number of terminals on the D and E side respectively.
6. Dimension b applies to the metallized terminal. If the terminal has the optional radius on the other end of the terminal, dimension b should not be measured in that radius area.
7. Coplanarity applies to the terminals and all other bottom surface metallization.
8. NJ in the variation code refers to a package which is not currently JEDEC registered.

Figure 9. Carrier tape for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

1. Measured from centerline of sprocket hole to centerline of pocket.
2. Cumulative tolerance of sprocket holes is ± 0.20 .
3. Measured from centerline of sprocket hole to centerline of pocket.
4. Other material available.
5. All dimensions are in millimeters unless otherwise stated.

Table 13. Carrier tape dimensions

Symbol	Dimensions
A0	1.80 ± 0.05
B0	2.25 ± 0.05
K0	0.60 ± 0.05
F	3.50 ± 0.05
P1	4.00 ± 0.1
D1	1.00 min.
T	0.25 ± 0.03
G	0.75 min.
E2	6.25 min.
W	$8.00 + 0.3 / -0.1$

Figure 10. Reel information for QFN12 (1.7 x 2.0 mm) - 0.40 mm pitch

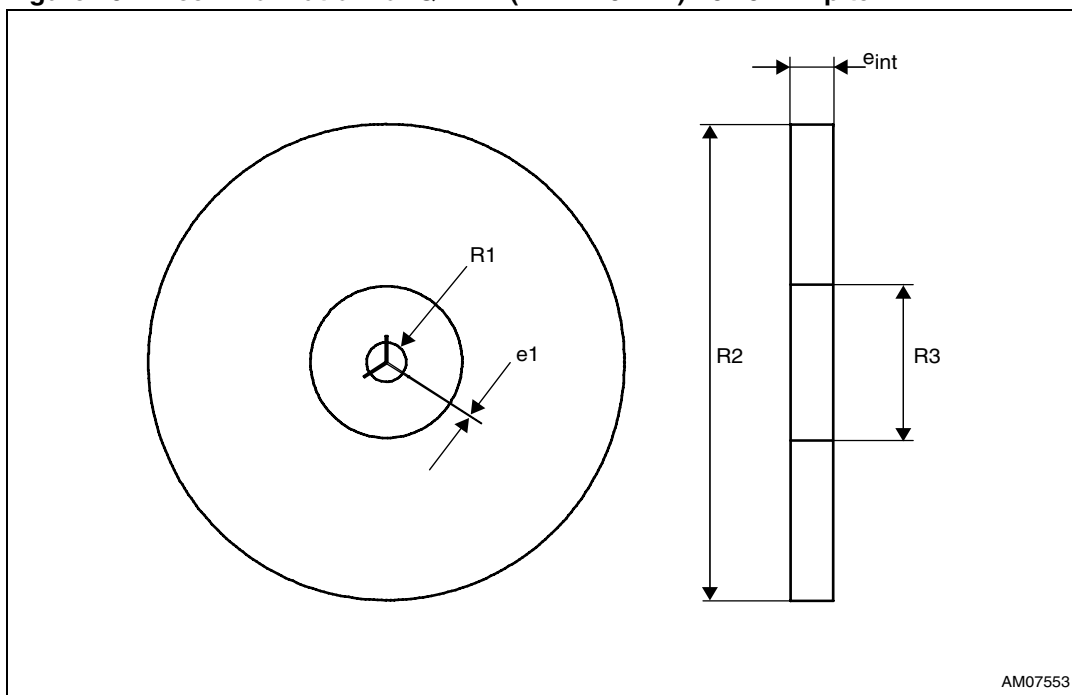


Table 14. Reel dimensions

mm	R1	R2	R3
Reel 7"	13	180	60

9 Revision history

Table 15. Document revision history

Date	Revision	Changes
19-Jun-2012	1	Initial release.

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